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STBV101K0RD4

# GaN 50V, 900W, 915MHz RF Power Transistor

## **Description**

The STBV101K0RD4 is a 900W capable, push pull, internally matched GaN HEMT, ideal for ISM or RF energy applications at 915MHz

In typical CW operation, it can deliver 900W under water cooling condition, and 850W CW under air cooling condition.

There is no guarantee of performance when this part is used outside of stated frequencies.

Typical RF performance at 915MHz applications

Vds=50V, Vgs=-4.2V, CW, Tc=25 degree C

	Freq	P1dB	P1dB	P1dB	P1dB	P3dB	P3dB	P3dB
	(MHz)	(dBm)	(W)	Eff(%)	Gain(dB)	(dBm)	(W)	Eff(%)
Water cooling	915	59.09	810.2	79	18.74	59.65	923	82
Air cooling	915	59.08	809.9	78	18.65	59.58	908	80

Recommended driver: ITGV20040J2 (50V LDMOS)

### **Applications**

- 915MHz RF Energy
- P band power amplifier
- Avionics Power Amplifier

### **Important Note: Proper Biasing Sequence for GaN HEMT Transistors**

#### Turning the device ON

- 1. Set VGS to the pinch--off (VP) voltage, typically –5 V
- 2. Turn on VDS to nominal supply voltage
- 3. Increase VGS until IDS current is attained
- 4. Apply RF input power to desired level

## Turning the device OFF

- 1. Turn RF power off
- 2. Reduce VGS down to VP, typically -5 V
- 3. Reduce VDS down to 0 V
- 4. Turn off VGS

### **Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
DrainSource Voltage	V <sub>DSS</sub>	+200	Vdc
GateSource Voltage	V <sub>GS</sub>	-8 to +0.5	Vdc
Operating Voltage	V <sub>DD</sub>	55	Vdc
Maximum gate current	lgs	141	mA
Storage Temperature Range	Tstg	-65 to +150	°C
Case Operating Temperature	T <sub>C</sub>	+150	°C
Operating Junction Temperature	TJ	+225	°C

#### Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit	
Thermal Resistance, Junction to Case by FEA	Polic	0.4	°C /W	
T <sub>C</sub> = 25°C, at Pd=250W	R⊕JC	0.4	-0 /٧٧	



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Table 3. Electrical Characteristics (TA = 25 $^{\circ}$ C unless otherwise noted)

#### DC Characteristics (Each path, measured on wafer prior to packaging)

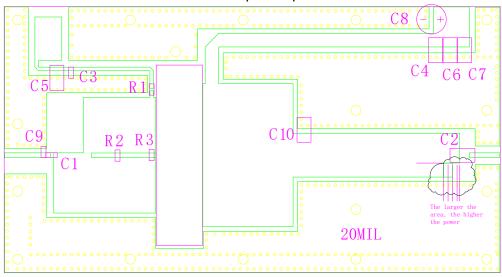
Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	VGS=-8V; IDS=70.5mA	V <sub>DSS</sub>		200		V
Gate Threshold Voltage	VDS =10V, ID = 70.5mA	$V_{GS(th)}$	-4	-	-2	V
Gate Quiescent Voltage	VDS =50V, IDS=500mA, Measured in Functional Test	$V_{GS(Q)}$		3.3		V

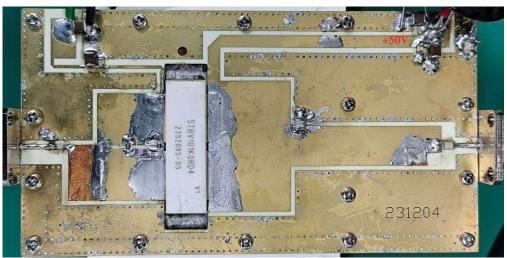
#### **Ruggedness Characteristics**

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Load mismatch capability	915MHz, Pout=900W pulse CW					
	All phase,	VSWR		10:1		
	No device damages					

# **Reference Circuit of Test Fixture Assembly Diagram**

DXF file upon request





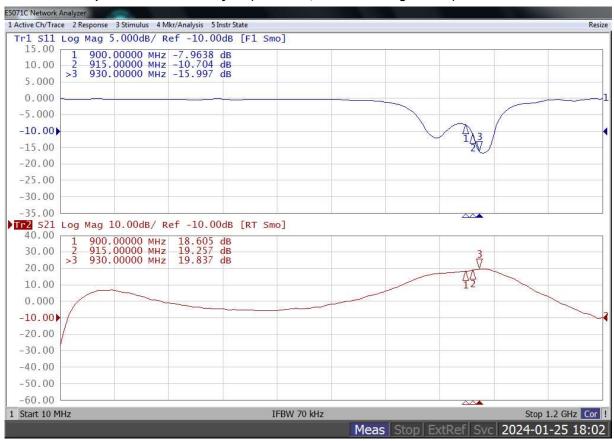


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Designator	Footprint	Comment	Quantity
C1, C3	0603	47pF	2
C2, C4	1210	47pF	2
C5, C6, C7	1210	10 uF/100V	3
C8		2200 uF/63V	1
C9	0603	12 pF	1
C10	1210	8.2 pF	1
R1, R2, R3	0603	10 Ω	3

### TYPICAL CHARACTERISTICS

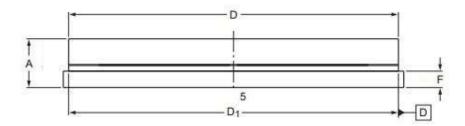
Figure 2: S11/S21 output from Network analyser (VDS= 50V, IDQ=500 mA Vgs =-3.3V)

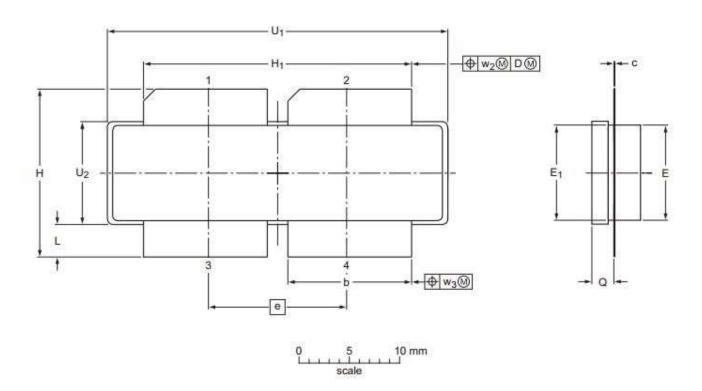




# **Package Outline**

Earless flanged ceramic package; 4 leads (1, 2—DRAIN, 3, 4—GATE, 5—SOURCE)





UNIT	A	b	С	D	D <sub>1</sub>	е	E	E <sub>1</sub>	F	Н	H <sub>1</sub>	L	Q	U <sub>1</sub>	U <sub>2</sub>	$W_2$	$W_2$
	4.7	11.81	0.18	31.55	31.52	13.72	9.50	9.53	1.75	17.12	25.53	3.48	2.26	32.39	10.29	0.25	0.25
mm	4.2	11.56	0.10	30.94	30.96	13.72	9.30	9.27	1.50	16.10	25.27	2.97	2.01	32.13	10.03	0.25	0.25
inches	0.185	0.465	0.007	1.242	1.241	0.540	0.374	0.375	0.069	0.674	1.005	0.137	0.089	1.275	0.405	0.01	0.01
inches	0.165	0.455	0.004	1.218	1.219	0.540	0.366	0.365	0.059	0.634	0.995	0.117	0.079	1.265	0.395	0.01	0.01

OUTLINE		REFERENCE		EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	IOOOE BATE
PKG-D4					03/12/2013



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# **Revision history**

#### **Table 4. Document revision history**

Date	Revision	Datasheet Status
2024/1/26	Rev 1.0	Preliminary datasheet creation

Application data based on: LSM-24-03

## Notice

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